## (a) Measurement of Intensity distribution of the Diffraction pattern.

Position of the detector is calculated as: Main Scale Reading + Vernier Scale Reading x Least Count Lease Count = 0.01 mm

S. No.	Position of the	Power (μA)	
	Main Scale Reading	Vernier Scale Reading	
1.	-5	0	0.0
2.	-5	63	0.1
3.	-5	85	0.3
4.	-4	16	0.4
5.	-4	52	0.5
6.	-3	9	0.3
7.	-3	22	0.2
8.	-3	34	0.1
9.	-3	60	0.0
10.	-3	89	0.1
11.	-2	1	0.4
12.	-2	36	0.7
13.	-2	69	3.5
14.	-2	97	5.2
15.	-1	26	7.7
16.	-1	58	10.4
17.	0	0	11.7
18.	0	15	11.7
19.	0	44	11.4
20.	0	74	10.0
21.	0	95	8.1
22.	1	15	6.6
23.	1	55	2.7
24.	1	89	1.5
25.	2	14	0.5
26.	2	53	0.0
27.	2	97	0.1
28.	3	12	0.3
29.	3	25	0.5
30.	3	50	0.7
31.	3	90	0.8

32.	4	26	0.6
33.	4	65	0.3
34.	5	12	0.1
35.	5	55	0.0

## (b) Measurement of the width of the slit

Reading for both edge is calculated as: Main Scale Reading + Vernier Scale Reading x Least Count Least Count = 0.01 mm

S. No.	Reading for right edge		Reading for left edge	
	Main Scale Reading	Vernier Scale Reading	Main Scale Reading	Vernier Scale Reading
1.	8.55	2	8.55	30
2.	8.55	3	8.55	35
3.	8.55	1	8.55	30